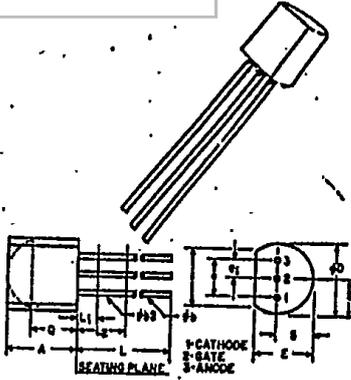


# Silicon Controlled Rectifier

**C203**
**0.8A RMS UP TO 400 VOLTS**


## MAXIMUM ALLOWABLE RATINGS

TYPE	REPETITIVE PEAK OFF-STATE VOLTAGE, $V_{DRM}^{(1)}$ $T_C = -65^\circ\text{C to } +125^\circ\text{C}$	REPETITIVE PEAK REVERSE VOLTAGE, $V_{DRM}^{(2)}$ $T_C = -65^\circ\text{C to } +125^\circ\text{C}$
C203Y	30 Volts	30 Volts
C203YY	60 Volts	60 Volts
C203A	100 Volts	100 Volts
C203B	200 Volts	200 Volts
C203C	300 Volts	300 Volts
C203D	400 Volts	400 Volts

## CHARACTERISTICS

TEST	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
Peak Reverse and Off-State Current (All Types)	$I_{RRM}$ or $I_{DRM}$	—	—	1.0	$\mu\text{A}$	$T_C = +25^\circ\text{C}$ , $R_{GK} = 1000$ ohms $V_{RRM} = V_{DRM} = \text{Rated Value}$ .
		—	—	50		$T_C = +125^\circ\text{C}$ , $R_{GK} = 1000$ ohms $V_{RRM} = V_{DRM} = \text{Rated Value}$ .
DC Gate Trigger Current	$I_{GT}$	—	—	200	$\mu\text{A dc}$	$T_C = +25^\circ\text{C}$ , $V_D = 6\text{Vdc}$ , $R_L = 100$ ohms.
		—	—	500		$T_C = -65^\circ\text{C}$ , $V_D = 6\text{Vdc}$ , $R_L = 100$ ohms.
DC Gate Trigger Voltage	$V_{GT}$	—	—	0.8	Vdc	$T_C = +25^\circ\text{C}$ , $V_D = 6\text{Vdc}$ , $R_L = 100$ ohms.
		—	—	1.0		$T_C = -65^\circ\text{C}$ , $V_D = 6\text{Vdc}$ , $R_L = 100$ ohms.
		0.1	—	—		$T_C = +125^\circ\text{C}$ , Rated $V_{DRM}$ , $R_L = 1000$ ohms.
Peak On-State Voltage	$V_{TM}$	—	—	1.5	V	$T_C = +25^\circ\text{C}$ , $I_{TM} = 1.0\text{A peak}$ , 1 msec. wide pulse, Duty Cycle $\leq 2\%$
Holding Current	$I_H$	—	—	5.0	mA dc	Anode source voltage = 12Vdc, $R_{GK} = 1000$ ohms. $T_C = +25^\circ\text{C}$ .
		—	—	10.0		$T_C = -65^\circ\text{C}$
Critical Rate-of-Rise-of Off-State Voltage	$dv/dt$	—	20	—	V/ $\mu\text{sec}$	$T_C = +125^\circ\text{C}$ , Rated $V_{DRM}$ , $R_{GK} = 1000$ ohms.
Circuit Commutated Turn-Off Time	$t_q$	—	15	—	$\mu\text{sec}$	$T_C = +125^\circ\text{C}$ , rectangular current waveform. Rate-of-rise of current $< 10\text{A}/\mu\text{sec}$ . Rate reversal of current $< 5\text{A}/\mu\text{sec}$ . $I_{TM} = 1\text{A}$ (50 $\mu\text{sec}$ . pulse). Rep. Rate = 60 pps. $V_{RRM} = \text{Rated}$ , $V_{RX} = 15\text{V Min.}$ , $V_{DRM} = \text{Rated}$ . Rate-of-rise of reapplied off-state voltage = 20V/ $\mu\text{sec.}$ ; Gate Bias = 0 Volts, 100 Ohms (during turn-off time interval).
Steady-State Thermal Resistance	$R_{\theta JC}$	—	—	125	$^\circ\text{C/W}$	Junction-to-case (flat side of case — temperature reference point).
	$R_{\theta JA}$	—	—	230		Junction-to-ambient (free convection).